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| FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of 1 | ATTORNEY DOCKET NO. | SERIAL NO. |
| | 4041J-000439 | 09/361,980 |
| | APPLICANT | |
| | Yasuaki Tsuzuki et al | |
| | FILING DATE | GROUP |
| July 28, 1999 | 1765 | |

U.S. PATENT DOCUMENTS

| Ref. Desig. | Examiner's Initials | Document Number | Date | Name | Class/ Subclass | (If appropriate) Filing Date |
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| 1. | LJM-E | Office action dated 9/03/2002 in Japanese Patent Application No. 10-217725 with English translation |
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Examiner: Lynette T. Vnez-Economou

Date Considered: 2/23/2003

EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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| 1. | L.T.M.-E | Office action dated 12/10/2002 in Japanese Patent Application No. 10-217725 with English translation |
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| Examiner: <i>Lynette T. Umeg-Eronimi</i> | Date Considered: <i>2/23/2003</i> |
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